

## 1. General description

Planar passivated very sensitive gate four quadrant triac in a SOT223 (SC-73) surface-mountable plastic package intended for applications requiring enhanced immunity to noise and direct interfacing to logic level ICs and low power gate drivers.

## 2. Features and benefits

- Direct interfacing to logic level ICs
- · Enhanced current surge capability
- Enhanced noise immunity
- High blocking voltage capability
- · Planar passivated for voltage ruggedness and reliability
- Surface-mountable package
- Triggering in all four quadrants
- Very sensitive gate in four quadrants

## 3. Applications

- General purpose low power motor control
- Home appliances
- Industrial process control
- · Low power AC Fan controllers

### 4. Quick reference data

#### Table 1. Quick reference data

| Symbol                 | Parameter                                | Conditions   |  | Min | Тур | Max  | Unit |
|------------------------|--|--|--|-----|-----|------|------|
| V <sub>DRM</sub>       | repetitive peak off-<br>state voltage    |  |  | -   | -   | 600  | V    |
| I <sub>T(RMS)</sub>    | RMS on-state current                     | full sine wave; $T_{sp} \le 105 \text{ °C}$ ; <u>Fig. 1;</u><br>Fig. 2; Fig. 3                         |  | -   | -   | 1    | А    |
| I <sub>TSM</sub>       | non-repetitive peak on-<br>state current | full sine wave; T <sub>j(init)</sub> = 25 °C;<br>t <sub>p</sub> = 20 ms; <u>Fig. 4</u> ; <u>Fig. 5</u> |  | -   | -   | 12.5 | А    |
|                        |  | full sine wave; T <sub>j(init)</sub> = 25 °C;<br>t <sub>p</sub> = 16.7 ms                              |  | -   | -   | 13.8 | А    |
| Tj                     | junction temperature                     |  |  | -   | -   | 125  | °C   |
| Static characteristics |  |  |  |     |     |      |      |
| I <sub>GT</sub>        | gate trigger current                     | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2+ G+;<br>T <sub>j</sub> = 25 °C; <u>Fig. 9</u>        |  | 0.2 | -   | 3    | mA   |

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### 4Q Triac

| Symbol                | Parameter                             | Conditions  | Min | Тур | Max | Unit |
|-----------------------|---------------------------------------|---|-----|-----|-----|------|
|                       |                                       | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2+ G-;<br>T <sub>j</sub> = 25 °C; <u>Fig. 9</u>   | 0.2 | -   | 3   | mA   |
|                       |                                       | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; \text{ T2- G-}; T_j = 25 \text{ °C}; Fig. 9$  | 0.2 | -   | 3   | mA   |
|                       |                                       | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2- G+;<br>T <sub>j</sub> = 25 °C; <u>Fig. 9</u>   | 0.2 | -   | 5   | mA   |
| I <sub>H</sub>        | holding current                       | V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <u>Fig. 11</u>   | -   | -   | 7   | mA   |
| V <sub>T</sub>        | on-state voltage                      | I <sub>T</sub> = 1.4 A; T <sub>j</sub> = 25 °C; <u>Fig. 12</u>  | -   | 1.3 | 1.6 | V    |
| Dynamic ch            | naracteristics                        | ·   |     |     |     |      |
| dV <sub>D</sub> /dt   | rate of rise of off-state voltage     | $V_{DM}$ = 402 V; T <sub>j</sub> = 110 °C; (V <sub>DM</sub> = 67% of V <sub>DRM</sub> ); exponential waveform; gate open circuit; Fig. 14 | 80  | -   | -   | V/µs |
| dV <sub>com</sub> /dt | rate of change of commutating voltage | $V_D$ = 400 V; T <sub>j</sub> = 110 °C; dI <sub>com</sub> /<br>dt = 0.44 A/ms; gate open circuit  | 0.5 | -   | -   | V/µs |

# 5. Pinning information

| Table 2. Pinning information |        |                 |                                    |                |  |  |  |
|------------------------------|--------|-----------------|------------------------------------|----------------|--|--|--|
| Pin                          | Symbol | Description     | Simplified outline                 | Graphic symbol |  |  |  |
| 1                            | T1     | main terminal 1 | 4                                  | T2-71          |  |  |  |
| 2                            | T2     | main terminal 2 |                                    | G<br>sym051    |  |  |  |
| 3                            | G      | gate            |                                    | Symoor         |  |  |  |
| 4                            | T2     | main terminal 2 | ☐1 ☐2 <b>☐</b> 3<br>SC-73 (SOT223) |                |  |  |  |

# 6. Ordering information

| Table 3. Ordering information |         |  |         |  |  |  |
|-------------------------------|---------|--|---------|--|--|--|
| Type number                   | Package | ge   |         |  |  |  |
|                               | Name    | Description  | Version |  |  |  |
| Z0103MN0                      | SC-73   | plastic surface-mounted package with increased heatsink; 4 leads | SOT223  |  |  |  |

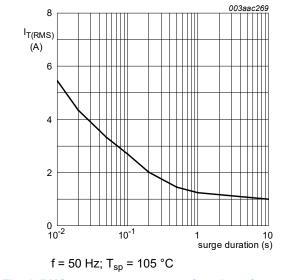


## 7. Limiting values

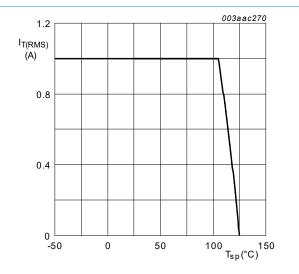
#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol              | Parameter                                | Conditions  | Min | Max  | Unit |
|---------------------|--|---|-----|------|------|
| V <sub>DRM</sub>    | repetitive peak off-state voltage        |   | -   | 600  | V    |
| I <sub>T(RMS)</sub> | RMS on-state current                     | full sine wave; T <sub>sp</sub> ≤ 105 °C; <u>Fig. 1; Fig. 2;</u><br><u>Fig. 3</u> | -   | 1    | A    |
| I <sub>TSM</sub>    | non-repetitive peak on-<br>state current | full sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 20 ms;<br>Fig. 4; Fig. 5           | -   | 12.5 | A    |
|                     |  | full sine wave; $T_{j(init)}$ = 25 °C; $t_p$ = 16.7 ms                            | -   | 13.8 | А    |
| l <sup>2</sup> t    | I <sup>2</sup> t for fusing              | t <sub>p</sub> = 10 ms; SIN   | -   | 0.78 | A²s  |
| dl <sub>T</sub> /dt | rate of rise of on-state current         | I <sub>G</sub> = 20 mA; T2+ G+  | -   | 50   | A/µs |
|                     |  | I <sub>G</sub> = 20 mA; T2+ G-  | -   | 50   | A/µs |
|                     |  | I <sub>G</sub> = 20 mA; T2- G-  | -   | 50   | A/µs |
|                     |  | I <sub>G</sub> = 20 mA; T2- G+  | -   | 20   | A/µs |
| I <sub>GM</sub>     | peak gate current                        |   | -   | 1    | А    |
| P <sub>GM</sub>     | peak gate power                          |   | -   | 2    | W    |
| P <sub>G(AV)</sub>  | average gate power                       | over any 20 ms period   | -   | 0.1  | W    |
| T <sub>stg</sub>    | storage temperature                      |   | -40 | 150  | °C   |
| Tj                  | junction temperature                     |   | -   | 125  | °C   |

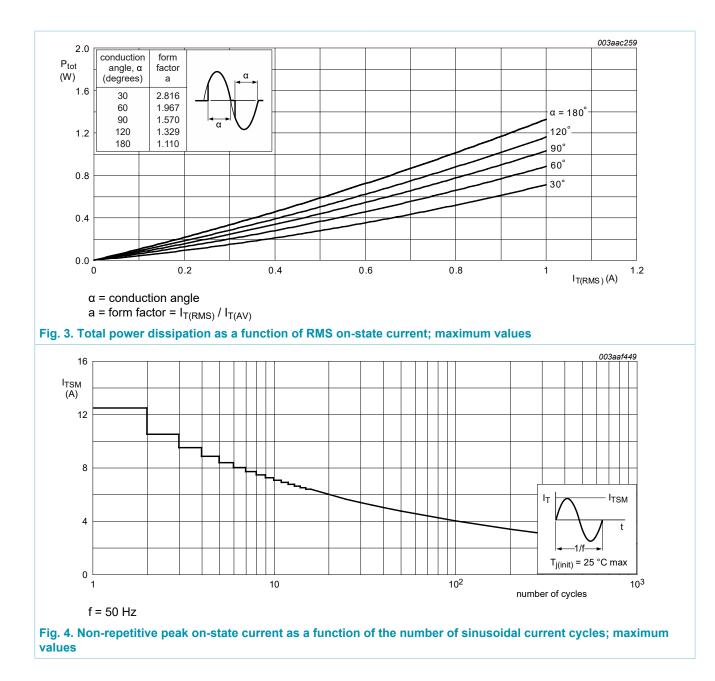






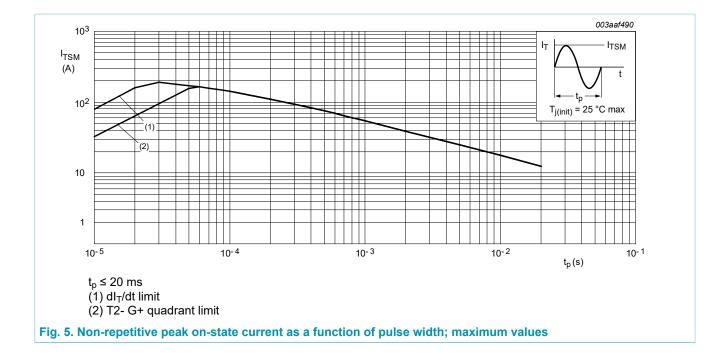


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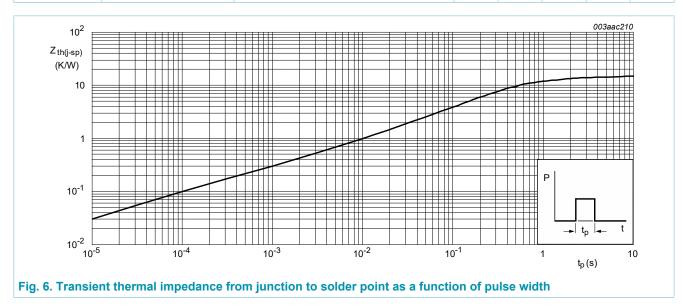
#### 4Q Triac





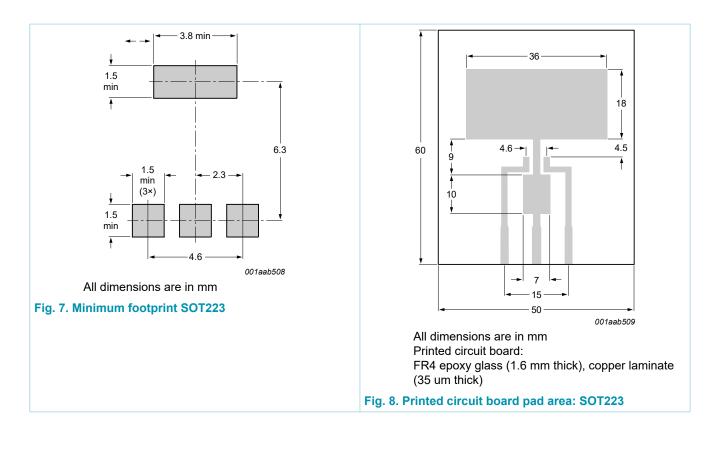
### 8. Thermal characteristics

| Table 5. The          | rmal characteristics                                       |   |     |     |     |      |
|-----------------------|--|---|-----|-----|-----|------|
| Symbol                | Parameter  | Conditions  | Min | Тур | Max | Unit |
| R <sub>th(j-sp)</sub> | thermal resistance<br>from junction to solder<br>point     | full cycle; <u>Fig. 6</u>   | -   | -   | 15  | K/W  |
| R <sub>th(j-a)</sub>  | thermal resistance<br>from junction to<br>ambient free air | in free air; printed-circuit board<br>mounted: minimum footprint; full cycle;<br>Fig. 7 | -   | 156 | -   | K/W  |
|                       |  | in free air; printed-circuit board<br>mounted: pad area; full cycle; <u>Fig. 8</u>      | -   | 70  | -   | K/W  |



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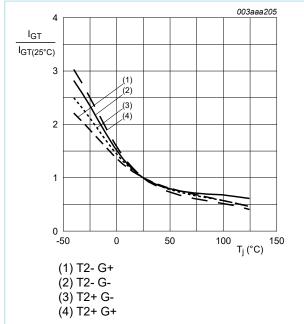


## 9. Characteristics

| Symbol                | Parameter                             | Conditions   | Min | Тур | Max | Unit |
|-----------------------|---------------------------------------|--|-----|-----|-----|------|
| Static chara          | acteristics                           |  |     |     |     |      |
| I <sub>GT</sub>       | gate trigger current                  | $V_D = 12 \text{ V}; I_T = 0.1 \text{ A}; \text{ T2+ G+};$<br>T <sub>j</sub> = 25 °C; Fig. 9                                 | 0.2 | -   | 3   | mA   |
|                       |                                       | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2+ G-;<br>T <sub>j</sub> = 25 °C; <u>Fig. 9</u>                              | 0.2 | -   | 3   | mA   |
|                       |                                       | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2- G-;<br>T <sub>j</sub> = 25 °C; <u>Fig. 9</u>                              | 0.2 | -   | 3   | mA   |
|                       |                                       | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T2- G+;<br>T <sub>j</sub> = 25 °C; <u>Fig. 9</u>                              | 0.2 | -   | 5   | mA   |
| ΙL                    | latching current                      | V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T2+ G+;<br>T <sub>j</sub> = 25 °C; <u>Fig. 10</u>                             | -   | -   | 7   | mA   |
|                       |                                       | V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T2+ G-;<br>T <sub>j</sub> = 25 °C; <u>Fig. 10</u>                             | -   | -   | 20  | mA   |
|                       |                                       | V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T2- G-;<br>T <sub>j</sub> = 25 °C; <u>Fig. 10</u>                             | -   | -   | 7   | mA   |
|                       |                                       | V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; T2- G+;<br>T <sub>j</sub> = 25 °C; <u>Fig. 10</u>                             | -   | -   | 7   | mA   |
| н                     | holding current                       | V <sub>D</sub> = 12 V; T <sub>j</sub> = 25 °C; <u>Fig. 11</u>  | -   | -   | 7   | mA   |
| √ <sub>T</sub>        | on-state voltage                      | I <sub>T</sub> = 1.4 A; T <sub>j</sub> = 25 °C; <u>Fig. 12</u>   | -   | 1.3 | 1.6 | V    |
| √ <sub>GT</sub>       | gate trigger voltage                  | V <sub>D</sub> = 12 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 25 °C;<br>Fig. 13  | -   | -   | 1   | V    |
|                       |                                       | V <sub>D</sub> = 600 V; I <sub>T</sub> = 0.1 A; T <sub>j</sub> = 125 °C;<br>Fig. 13  | 0.2 | -   | -   | V    |
| D                     | off-state current                     | V <sub>D</sub> = 600 V; T <sub>j</sub> = 125 °C  | -   | -   | 0.5 | mA   |
| Dynamic ch            | aracteristics                         |  |     |     |     |      |
| dV <sub>D</sub> /dt   | rate of rise of off-state voltage     | $V_{DM}$ = 402 V; T <sub>j</sub> = 110 °C; ( $V_{DM}$ = 67% of $V_{DRM}$ ); exponential waveform; gate open circuit; Fig. 14 | 80  | -   | -   | V/µs |
| dV <sub>com</sub> /dt | rate of change of commutating voltage | $V_D = 400 \text{ V}; \text{ T}_j = 110 \text{ °C}; \text{ dI}_{com}/$<br>dt = 0.44 A/ms; gate open circuit                  | 0.5 | -   | -   | V/µs |

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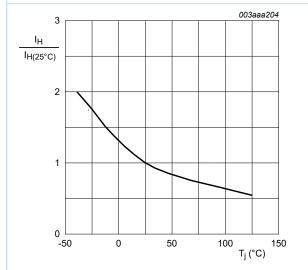
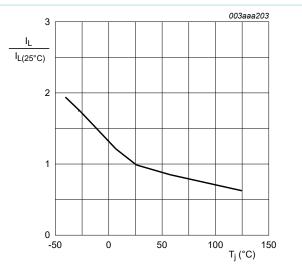
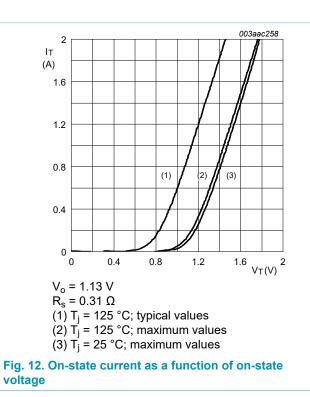


Fig. 11. Normalized holding current as a function of junction temperature

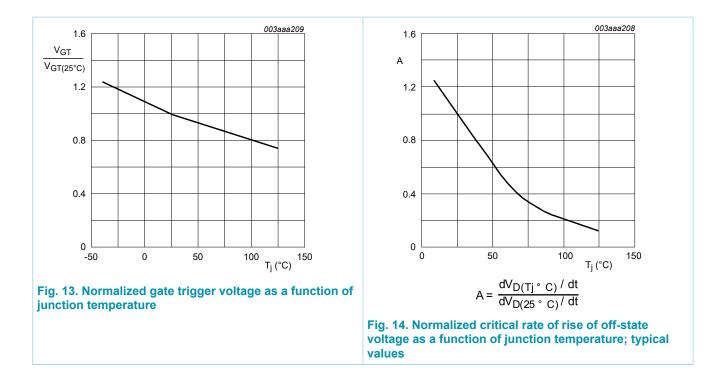




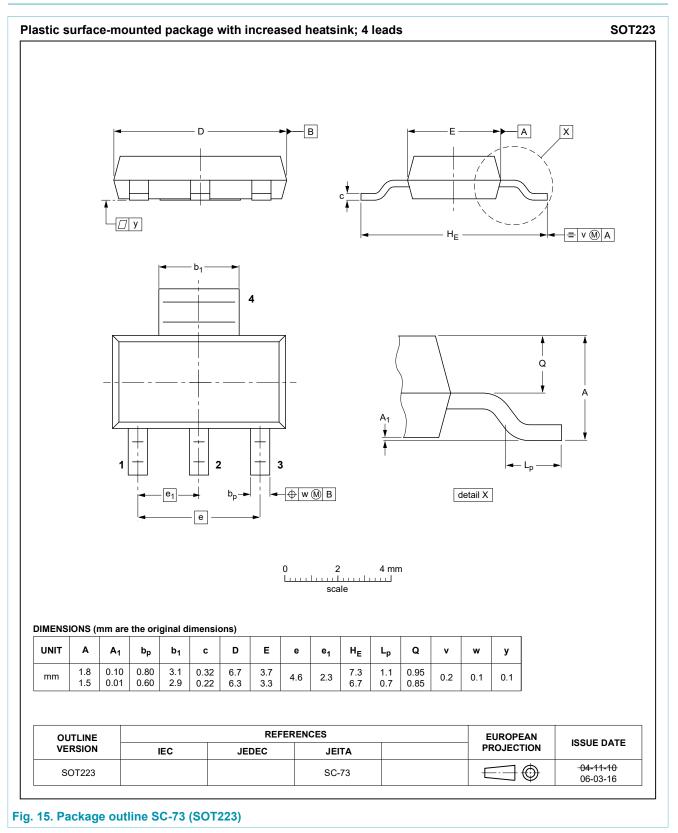


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## 10. Package outline



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# 11. Legal information

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| Document<br>status [1][2]            | Product<br>status [ <u>3]</u> | Definition  |
|--------------------------------------|-------------------------------|---|
| Objective<br>[short] data<br>sheet   | Development                   | This document contains data from<br>the objective specification for product<br>development. |
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